# Notice of References Cited Application/Control No. | Applicant(s)/Patent Under Reexamination | DANIELI, DAMON V. Examiner | Art Unit | Steven B. Theriault | 2179 | Page 1 of 3

# **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-5,382,972 A	01-1995	Kannes, Deno	348/14.07
*	В	US-5,491,743 A	02-1996	Shiio et al.	709/204
*	С	US-5,742,329 A	04-1998	Masunaga et al.	348/14.07
*	D	US-5,736,982 A	04-1998	Suzuki et al.	715/706
*	E	US-5,793,365 A	08-1998	Tang et al.	715/758
*	F	US-5,999,208 A	12-1999	McNerney et al.	348/14.08
*	G	US-6,014,135 A	01-2000	Fernandes, Antonio M.	715/744
*	Н	US-6,040,841 A	09-2000	Cohen et al.	345/473
*	ı	US-6,119,147 A	09-2000	Toomey et al.	709/204
*	j	US-6,192,395 B1	02-2001	Lerner et al.	709/204
* .	к	US-6,219,045 B1	04-2001	Leahy et al.	715/757
*	L	US-6,237,025 B1	05-2001	Ludwig et al.	709/204
*	М	US-6,330,022 B1	12-2001	Seligmann, Doree	348/14.08

# FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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# **NON-PATENT DOCUMENTS**

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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

#### 

Application/Control No.

# **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,496,201 B1	12-2002	Baldwin et al.	715/753
*	В	US-6,559,863 B1	05-2003	Megiddo, Nimrod	715/753
*	С	US-2003/0156134 A1	08-2003	Kim, Kyunam	345/753
*	D	US-2004/0006595 A1	01-2004	Yeh et al.	709/204
*.	Ε	US-2004/0028199 A1	02-2004	Carlson, Michael Pierre	379/93.21
*	F	US-6,772,195 B1	08-2004	Hatlelid et al.	709/204
*	G	US-6,784,901 B1	08-2004	Harvey et al.	715/757
*	Н	US-2004/0179038 A1	09-2004	Blattner et al.	345/751
*	1	US-2004/0179039 A1	09-2004	Blattner et al. 345/7	
*	J	US-6,807,562 B1	10-2004	Pennock et al.	709/204
*	К	US-2004/0221224 A1	11-2004	Blattner et al. 715/50	
*	L	US-2004/0246121 A1	12-2004	Beyda, William J. 340/500	
*	М	US-2005/0181878 A1	08-2005	Danieli et al.	463/042

# FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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#### **NON-PATENT DOCUMENTS**

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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Applicant(s)/Patent Under

# Notice of References Cited 10/671,361 Reexamination DANIELI, DAMON V. Examiner Steven B. Theriault 2179 Reexamination DANIELI, DAMON V. Page 3 of 3

Application/Control No.

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2005/0210394 A1	09-2005	Crandall et al.	715/752
*	В	US-7,039,677 B2	05-2006	Fitzpatrick et al.	709/204
*	С	US-7,111,045 B2	09-2006	Kato et al.	709/205
*	D	US-2006/0235932 A1	10-2006	Celi et al.	709/207
*	E	US-7,124,372 B2	10-2006	Brin, Glen David	715/751
*	F	US-7,143,356 B1	11-2006	Shafrir et al.	715/751
*	G	US-7,181,690 B1	02-2007	Leahy et al.	715/706
*	Н	US-7,185,054 B1	02-2007	Ludwig et al.	709/204
*	ı	US-7,234,117 B2	06-2007	Zaner et al.	715/758
*	J	US-7,240,093 B1	07-2007	Danieli et al.	709/205
*	К	US-7,278,921 B1	10-2007	Fujisawa et al.	463/42
F	L	US-			
	М	US-			

# **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name ·	Classification
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#### NON-PATENT DOCUMENTS

		NON-FATENT DOCUMENTS
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Applicant(s)/Patent Under